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APPLICATION NO.		FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/711,673		09/30/2004	Chyh-Yih Chang	13714-US-PA	5672
31561	7590	05/02/2005		EXAMINER	
•		NTELLECTUAL P	FORDE, REMMON R		
7 FLOOR-1, NO. 100 ROOSEVELT ROAD, SECTION 2				ART UNIT	PAPER NUMBER
TAIPEI, 100			2826		
TAIWAN				DATE MAILED: 05/02/2005	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)					
	10/711,673	CHANG ET AL.					
Office Action Summary	Examiner	Art Unit	_				
	Remmon R. Fordé	2826					
The MAILING DATE of this communication Period for Reply	appears on the cover sheet wi	th the correspondence address					
A SHORTENED STATUTORY PERIOD FOR RE THE MAILING DATE OF THIS COMMUNICATIO - Extensions of time may be available under the provisions of 37 CFI after SIX (6) MONTHS from the mailing date of this communication - If the period for reply specified above, the maximum statutory pe - Failure to reply within the set or extended period for reply will, by st Any reply received by the Office later than three months after the mearned patent term adjustment. See 37 CFR 1.704(b).	N. R 1.136(a). In no event, however, may a re- reply within the statutory minimum of thirt- riod will apply and will expire SIX (6) MON atute, cause the application to become AB	eply be timely filed y (30) days will be considered timely. THS from the mailing date of this communication. ANDONED (35 U.S.C. § 133).					
Status		· · · · · · · · · · · · · · · · · · ·					
1) Responsive to communication(s) filed on 3	0 September 2004.						
3) Since this application is in condition for allo		ers, prosecution as to the merits is					
closed in accordance with the practice und	•	•					
Disposition of Claims							
4)⊠ Claim(s) <u>1-20</u> is/are pending in the applicat	tion						
	4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.							
6)⊠ Claim(s) <u>1-20</u> is/are rejected.	·						
7) Claim(s) is/are objected to.							
8) Claim(s) are subject to restriction an	nd/or election requirement.						
Application Papers							
9) The specification is objected to by the Exam	niner.						
· _ ·	☑ The drawing(s) filed on <u>30 September 2004</u> is/are: a)☑ accepted or b)☐ objected to by the Examiner.						
Applicant may not request that any objection to		· ·					
Replacement drawing sheet(s) including the cor	rection is required if the drawing(s) is objected to. See 37 CFR 1.121(d).					
11) The oath or declaration is objected to by the	Examiner. Note the attached	Office Action or form PTO-152.					
Priority under 35 U.S.C. § 119							
12)⊠ Acknowledgment is made of a claim for fore	eign priority under 35 U.S.C. &	119(a)-(d) or (f).					
a) ⊠ All b) □ Some * c) □ None of:							
1. Certified copies of the priority docum							
2. Certified copies of the priority docum	ents have been received in A	pplication No					
3. Copies of the certified copies of the p	priority documents have been	received in this National Stage					
application from the International Bu	reau (PCT Rule 17.2(a)).						
* See the attached detailed Office action for a	list of the certified copies not	received.					
Attachment(s)							
1) Notice of References Cited (PTO-892)		ummary (PTO-413)					
2) ☑ Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) ☑ Information Disclosure Statement(s) (PTO-1449 or PTO/SB.	/08) 5) ☐ Notice of In)/Mail Date formal Patent Application (PTO-152)					
Paper No(s)/Mail Date <u>9/30/04</u> .	6) Other:		-				

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DETAILED ACTION

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-20 are rejected under 35 U.S.C. 102(b) as being anticipated by Herbert.

Regarding claims 1, 11, 15 and 16, referencing Figure 1B, Herbert discloses a high voltage device provided with: a first type substrate (29); a first type epitaxial silicon layer (26) disposed in the first type substrate; a first type well (24) disposed in the first type epitaxial silicon layer; a second type well (23 & 28) disposed in the first type epitaxial silicon layer, wherein the second type well comprises a second type lightly doped region (23) and a second type heavily doped region (28), the second type lightly doped region (23) is located next to the first type well (24) and the second heavily doped region (28) is located underneath a portion of the first type well (24) and the second type lightly doped region (23); a gate structure (21) disposed on a portion of the first type well (24) and the second type lightly doped region (27) and a second type second doped region (23); a second type first doped region (27) and a second type second doped region (22)disposed in the second type lightly doped region (23) and the first type well (24) on each side of the gate structure (21) respectively; a first isolation structure (25) disposed in the second type lightly doped region (23) and between the gate structure (21) and the second type first

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doped region (27); and a first type doped region (19) disposed in the first type well (24) and adjacent to the second type second doped region (22). (Column 1, line 62 – Column 2, line 16.)

Regarding claims 2 and 3, referencing Figure 1B, Herbert further discloses that the second type lightly doped region (23), the first type well (24) and the second type second doped region (22) together constitute a parasitic bipolar transistor, and the second type heavily doped region (28), the first type well (24) and the second type second doped region (22) together constitute another parasitic bipolar transistor so that a pulse current entering from the second type first doped region (27) is able to channel away through the second type second doped region (22) after passing through the two parasitic bipolar transistors. (Column 1, line 62 – Column 2, line 16.)

Regarding claims 4, 5, 12 and 13, referencing Figure 1B, Herbert further discloses a second isolation structure made of a field oxide isolation structure. (Column 1, line 62 – Column 2, line 16.)

Regarding claims 6 and 14, referencing Figure 1B, Herbert further discloses that the first isolation structure (25) is a field oxide isolation structure.

Regarding claims 7 and 17, referencing Figure 1B, Herbert further discloses that the second type first doped region (27), the second type lightly doped region (23) and the second type heavily doped region (28) together serves as a drain and the second type second doped region (22) serves as a source. (Column 1, line 62 – Column 2, line 16.)

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Regarding claims 8 and 18, referencing Figure 1B, Herbert further discloses that the second type lightly doped region (23) comprises a high voltage second type well.

Regarding claims 9 and 19, referencing Figure 1B, Herbert further discloses that the second type heavily doped region (28) comprises a second type buried layer.

Regarding claims 10 and 20, referencing Figure 1B, Herbert further discloses that the first type is a P-type and the second type is an N-type.

Contact Information

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Remmon R. Fordé whose telephone number is (571) 272-1916. The examiner can normally be reached on Monday-Thursday (8:00-6:30).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan J. Flynn can be reached on (571) 272-1915. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Remmon R. Fordé

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